

Notice of R ferenc s Cit d

Application/Control I

Applicant(s)/Patent Under Reexamination FIGIEL ET AL.

Examiner Thao T. Tran Art Unit 1711

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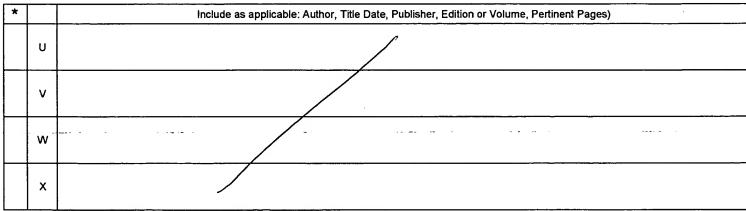
U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,716,441	02-1998	Nguyen et al.	106/207.1
	В	US-6,280,515	08-2001	Lydzinski et al.	106/122
	С	US-6,379,447	04-2002	Eden et al.	106/205.01
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	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS



*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.